



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	RDS(ON) max	Ι _{D MAX} T _A = +25°C
Q1	20V	$40m\Omega @ V_{GS} = 4.5V$	4.7A
N-Channel	200	65mΩ @ V _{GS} = 2.5V	3.7A
Q2	-20V	90mΩ @ V _{GS} = -4.5V	-3.2A
P-Channel	-200	137mΩ @ V _{GS} = -2.5V	-2.6A

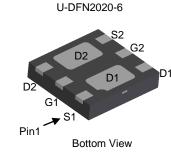
Description

This MOSFET is designed to minimize the on-state resistance $(R_{DS(ON)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Load Switch
- Power Management Functions
- Portable Power Adaptors



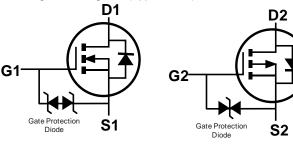


Features

- Low On-Resistance
- Low Input Capacitance
- Low Profile, 0.6mm Max Height
- ESD protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

- Case: U-DFN2020-6
- Case Material: Molded Plastic, "Green" Molding Compound; UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe; Solderable per MIL-STD-202, Method 208 @
- Terminal Connections: See Diagram Below
- Weight: 0.0065 grams (Approximate)



Q1 N-CHANNEL MOSFET

Q2 P-CHANNEL MOSFET

Internal Schematic

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC2041UFDB -7	U-DFN2020-6	3,000/Tape & Reel
DMC2041UFDB -13	U-DFN2020-6	10,000/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

 See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

U-DFN2	020-6
D4	ΥM

 $\begin{array}{l} \mathsf{D4} = \mathsf{Product} \ \mathsf{Type} \ \mathsf{Marking} \ \mathsf{Code} \\ \mathsf{YM} = \mathsf{Date} \ \mathsf{Code} \ \mathsf{Marking} \\ \mathsf{Y} = \mathsf{Year} \ (\mathsf{ex:} \ \mathsf{B} = 2014) \\ \mathsf{M} = \mathsf{Month} \ (\mathsf{ex:} \ 9 = \mathsf{September}) \end{array}$

Date	Code	Key
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Year	201	4	2015		2016	20	17	2018		2019	2	2020
Code	В		С		D	E		F		G		Н
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	Ν	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	Q1 N-CHANNEL	Q2 P-CHANNEL	Units
Drain-Source Voltage			V _{DSS}	20	-20	V
Gate-Source Voltage			V _{GSS}	±12	±12	V
Continuous Drain Current (Note 5) // 45)/	Steady State	T _A = +25°C T _A = +70°C	ID	4.7 3.8	-3.2 -2.5	А
Continuous Drain Current (Note 5) $V_{GS} = 4.5V$	t < 5s	T _A = +25°C T _A = +70°C	ID	6.1 4.9	-4.1 -3.2	А
Maximum Continuous Body Diode Forward Curre	Is	2	-1.5	А		
Pulsed Drain Current (10µs pulse, duty cycle = 1	I _{DM}	30	-18	А		

Thermal Characteristics

Characteristic	Symbol	Value	Units		
Total Power Dissipation (Note 5)	Steady State	D	1.4	W	
Total Power Dissipation (Note 5)	t < 5s	PD	2.2		
Thermal Desistance, Junction to Ambient (Note 5)	Steady State	6	92		
Thermal Resistance, Junction to Ambient (Note 5)	t < 5s	$R_{ heta JA}$	55	°C/W	
Thermal Resistance, Junction to Case (Note 5)	$R_{ ext{ heta}JC}$	30			
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C		

Electrical Characteristics Q1 N-CHANNEL (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)			- 71-			
Drain-Source Breakdown Voltage	BV _{DSS}	20	_	_	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	1.0	μA	$V_{DS} = 20V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±10	μA	$V_{GS} = \pm 8V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	0.35	—	1.4	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance	Descent		23	40	mΩ	$V_{GS} = 4.5V, I_D = 4.2A$
	R _{DS} (ON)	_	26	65	11152	$V_{GS} = 2.5V, I_D = 3.3A$
Diode Forward Voltage	V _{SD}	_	0.7	1.2	V	$V_{GS} = 0V$, $I_S = 4.4A$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	Ciss	_	713	—	pF	
Output Capacitance	C _{oss}	—	80	—	pF	[−] V _{DS} = 10V, V _{GS} = 0V, − f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	68	—	pF	1 - 1.00012
Gate Resistance	Rg	_	15	—	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$
Total Gate Charge ($V_{GS} = 4.5V$)	0		8	_	nC	
Total Gate Charge (V _{GS} = 8V)	Qg		15	_	nC	
Gate-Source Charge	Q _{gs}		1.0	_	nC	$V_{DS} = 10V, I_D = 5.5A$
Gate-Drain Charge	Q _{gd}	_	1.1	_	nC	
Turn-On Delay Time	t _{D(on)}	-	3.6	—	ns	
Turn-On Rise Time	tr	-	15.9	—	ns	$V_{DD} = 10V, V_{GS} = 4.5V,$
Turn-Off Delay Time	t _{D(off)}	_	16.0	_	ns	$R_L = 2.3\Omega, R_G = 1\Omega$
Turn-Off Fall Time	t _f	_	2.6	_	ns	
Body Diode Reverse Recovery Time	trr	_	6.6	_	nS	I _S = 4.4A, dl/dt = 100A/µs
Body Diode Reverse Recovery Charge	Qrr		1.2	_	nC	I _S = 4.4A, dl/dt = 100A/µs

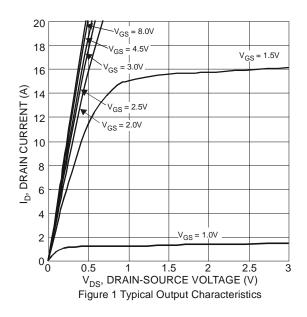
 Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. Copper, single sided.
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing. Notes:

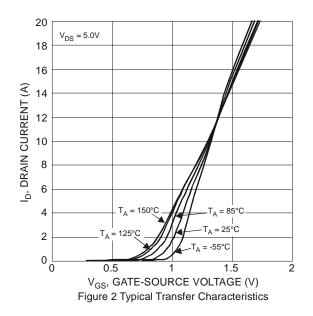


Electrical Characteristics Q2 P-CHANNEL (@T_A = +25°C, unless otherwise specified.)

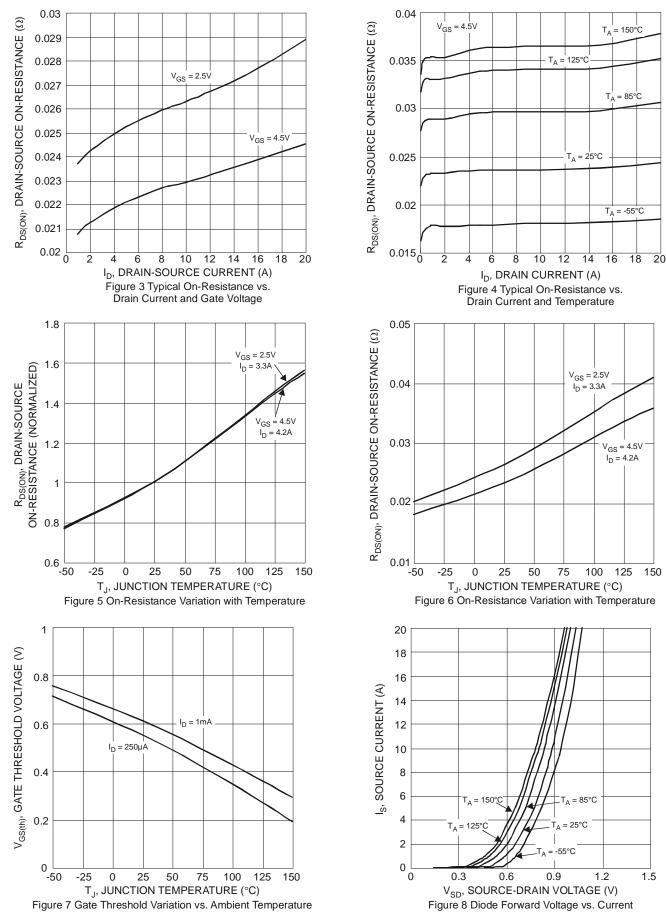
Characteristic	Symbol	Min	Тур	Мах	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)		1	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		1	
Drain-Source Breakdown Voltage	BV _{DSS}	-20	_		V	$V_{GS} = 0V, I_D = -250 \mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}		_	-1.0	μA	$V_{DS} = -20V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	—	±10	μA	$V_{GS} = \pm 8V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)	÷					•
Gate Threshold Voltage	V _{GS(th)}	-0.35	—	-1.4	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$
Static Drain-Source On-Resistance	D	_	59	90		$V_{GS} = -4.5V, I_D = -2.9A$
Static Drain-Source On-Resistance	Rds (ON)	_	76	137	mΩ	$V_{GS} = -2.5V, I_D = -2.3A$
Diode Forward Voltage	V _{SD}	_	-0.65	-1.2	V	$V_{GS} = 0V, I_{S} = -3.0A$
DYNAMIC CHARACTERISTICS (Note 7)	÷					•
Input Capacitance	Ciss	—	881	—	pF	
Output Capacitance	Coss	_	84	_	pF	V _{DS} = -10V, V _{GS} = 0V, − f = 1.0MHz
Reverse Transfer Capacitance	Crss	—	67	—	pF	
Gate Resistance	Rg	—	14.3	—	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$
Total Gate Charge (V _{GS} = -4.5V)		—	11	—	nC	
Total Gate Charge (V _{GS} = -8V)	Qg	_	18	_	nC	
Gate-Source Charge	Q _{gs}	_	1.5	_	nC	V _{DS} = -10V, I _D = -3.7A
Gate-Drain Charge	Q _{gd}		2.3		nC	
Turn-On Delay Time	t _{D(on)}	_	5.0	_	ns	
Turn-On Rise Time	tr	_	9.5	_	ns	V _{DD} = -10V, V _{GS} = -4.5V,
Turn-Off Delay Time	t _{D(off)}		29.7		ns	$R_L = 3.3\Omega, R_G = 1\Omega$
Turn-Off Fall Time	t _f		20.4		ns	
Body Diode Reverse Recovery Time	trr	—	23.6	—	nS	I _S = -3.0A, dI/dt = 100A/µs
Body Diode Reverse Recovery Charge	Qrr	—	11.4	—	nC	I _S = -3.0A, dl/dt = 100A/µs

Notes: 6. Short duration pulse test used to minimize self-heating effect. 7. Guaranteed by design. Not subject to product testing.

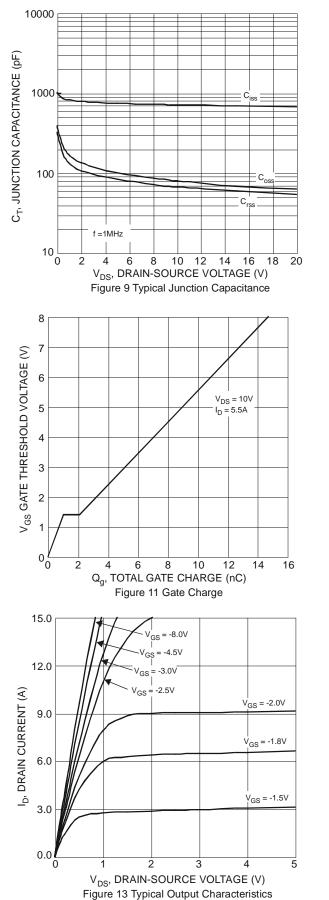












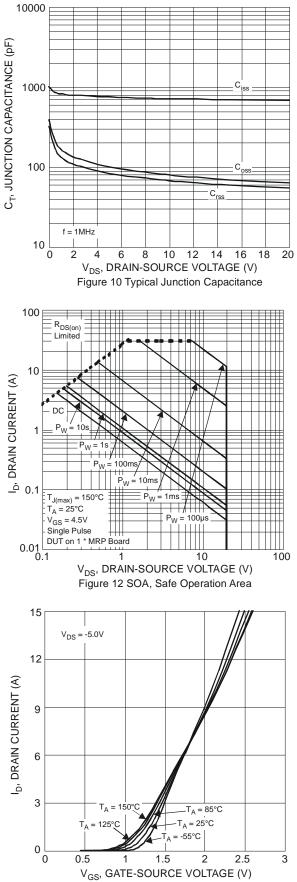
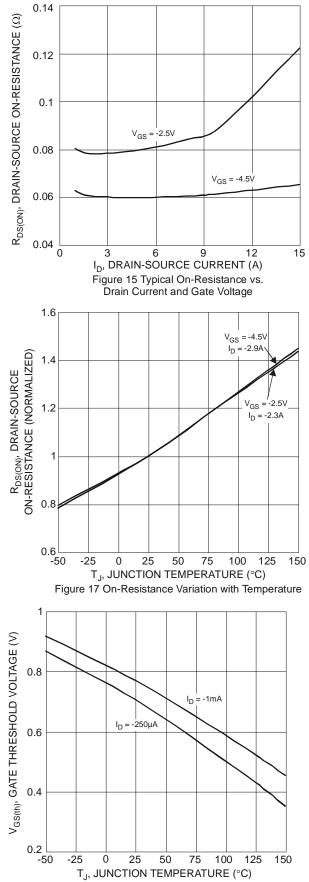


Figure 14 Typical Transfer Characteristics





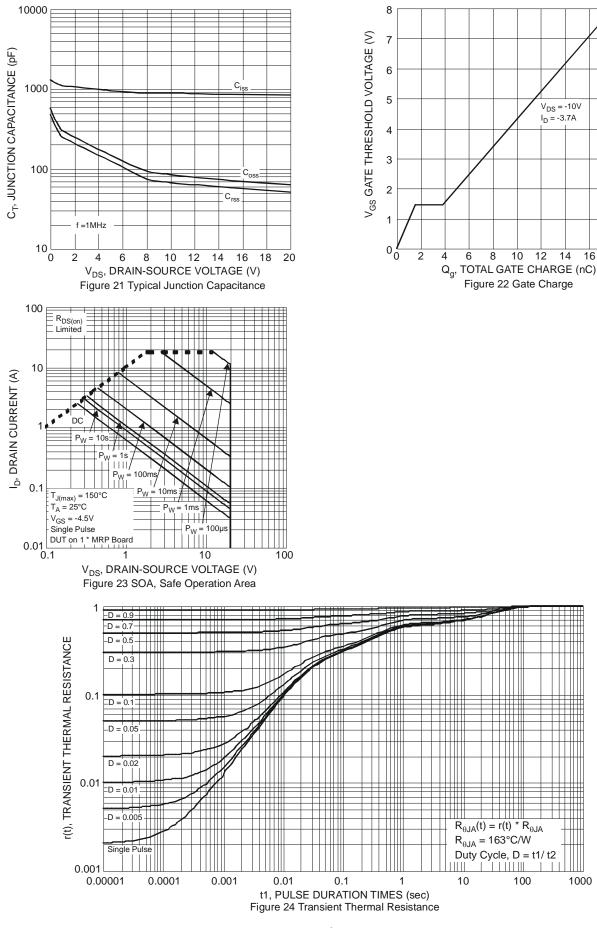
0.1 $R_{\mathsf{DS}(\mathsf{ON})^{*}}$ DRAIN-SOURCE ON-RESISTANCE (Ω) $V_{GS} = 4.5V$ $T_A = 150^{\circ}C$ 0.09 $T_A = 125^{\circ}C$ 0.08 T_A = 85°C 0.07 $T_A = 25^{\circ}C$ 0.06 0.05 T_A = -55°C 0.04 0.03 0 3 6 9 12 15 I_D, DRAIN CURRENT (A) Figure 16 Typical On-Resistance vs. Drain Current and Temperature 0.12 $R_{\text{DS}(\text{ON})^{\text{\prime}}}$ DRAIN-SOURCE ON-RESISTANCE (Ω) V_{GS} = -2.5V I_D = -2.3A 0.1 0.08 V_{GS} = -4.5V I_D = -2.9A 0.06 0.04 0.02 -50 -25 0 25 50 75 100 125 150 T_J, JUNCTION TEMPERATURE (°C) Figure 18 On-Resistance Variation with Temperature 15 12 I_S, SOURCE CURRENT (A) 9 6 85°C $= 150^{\circ}$ TA 3 25°C 125 -55°C 0∟ 0

0 0.3 0.6 0.9 1.2 1.5 V_{SD}, SOURCE-DRAIN VOLTAGE (V) Figure 20 Diode Forward Voltage vs. Current

Figure 19 Gate Threshold Variation vs. Ambient Temperature



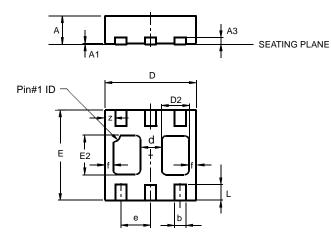
18 20





Package Outline Dimensions

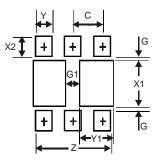
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the version.



	U-DFN	2020-6					
	Тур	e B					
Dim	Min Max Typ						
Α	0.545	0.605	0.575				
A1	0	0.05	0.02				
A3	_	_	0.13				
b	0.20	0.30	0.25				
D	1.95	2.075	2.00				
d	_	_	0.45				
D2	0.50	0.70	0.60				
е	_	_	0.65				
Е	1.95	2.075	2.00				
E2	0.90	1.10	1.00				
f	_	_	0.15				
L	0.25	0.35	0.30				
z	_	_	0.225				
All	Dimens	ions in	mm				

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	1.67
G	0.20
G1	0.40
X1	1.0
X2	0.45
Y	0.37
Y1	0.70
С	0.65



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